

<b>Notice of References Cited</b>	Application/Control No. 10/797,582		Applicant(s)/Patent Under Reexamination SHANG ET AL.	
	Examiner Jill Gray		Art Unit 1794	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,114,887 A	05-1992	Sekine et al.	501/95.1
*	B	US-2002/0006865 A1	01-2002	Morikawa et al.	502/200
*	C	US-2002/0151434 A1	10-2002	Domen et al.	502/200
*	D	US-2002/0169076 A1	11-2002	Takeshi et al.	502/350
*	E	US-6,680,277 B2	01-2004	Morikawa et al.	502/182
*	F	US-6,743,749 B2	06-2004	Morikawa et al.	502/349
*	G	US-6,835,688 B2	12-2004	Morikawa et al.	502/200
*	H	US-6,878,666 B2	04-2005	Domen et al.	502/200
*	I	US-2006/0264525 A1	11-2006	Ohwaki et al.	522/018
*	J	US-7,211,513 B2	05-2007	Remington et al.	438/680
*	K	US-7,491,349 B2	02-2009	Takahashi et al.	252/520.22
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2002321907 A	11-2002	Japan	AOKI et al.	C01B 13/14
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.